Features

- SRAM based FPGA designed for Space use
 - 280K equivalent ASIC gates
 - Unlimited reprogrammability
 - SEE hardened cells (Configuration RAM, FreeRAM[™], DFF, JTAG, I/O buffers)
 - No need for Triple Modular Redundancy (TMR)
- FreeRAM™:
 - 115200 Bits of Distributed RAM
 - 32x4 RAM blocks organization
 - Independent of Logic Cells
 - Single/Dual Port capability
 - Synchronous/Asynchronous capability
- Global Reset Option
- 8 Global Clocks and 4 Fast Clocks
- 8 LVDS transceivers and 8 LVDS receivers
- Cold sparing and PCI Compliant I/Os
 - 308 for 472pins MCGA package
 - 150 for 256pins MQFPF package
- Flexible Configuration modes
 - Master/Slave Capability
 - Serial/Parallel Capability
 - Check of the data during FPGA configuration
- Self Integrity Check (SIC) of the configuration during FPGA operation
- Performance
 - 100 MHz Internal Performance
 - 50MHz System Performance
 - 10ns 32X4 FreeRAM™ access time
- Operating range
 - Voltages
 - 1.65V to 1.95V (Core)
 - 3V to 3.6V (Clustered I/Os)
 - Temperature
 - - 55 ℃ to +125 ℃
- Radiation Performance
 - Total Dose tested up to 300 krads (Si)
 - No single event latch-up below a LET of 80 MeV/mg/cm2
- ESD better than 2000V
- Quality Grades
 - QML-Q or V
 - ESCC
- Ceramic packages
 - 256pins MQFPF (150 I/Os, 8 LVDS Tx and 8 LVDS Rx)
 - 472pins MCGA (308 I/Os, 8 LVDS Tx and 8 LVDS Rx)
- Design Kit including
 - ATF280E and Configurator Samples
 - Evaluation Board
 - Software Design Tools
 - ISP Cable/Dongle



Rad Hard Reprogrammable FPGA

ATF280E

Advance Information



7750A-AERO-07/07



1. Description

The ATF280E is a radiation hardened SRAM-based reprogrammable FPGA. It has been especially designed for space application by implementing hardened cells and permanent selfintegrity check mechanism.

The ATF280E is manufactured using the ATMEL 0.18µ rad-hard AT58KRHA CMOS technology.

The Atmel architecture is developed to provide the highest levels of performance, functional density and design flexibility in an FPGA. The cells in the Atmel array are small, efficient and can implement any pair of Boolean functions of (the same) three inputs or any single Boolean function of four inputs. The cell's small size leads to arrays with large numbers of cells, greatly multiplying the functionality in each cell. A simple, high-speed busing network provides fast, efficient communication over medium and long distances.

The ATF280E FPGA offers a patented distributed 10 ns SEU hardened SRAM capability where the RAM can be used without losing logic resources. Multiple independent, synchronous or asynchronous, dual port or single port RAM functions (FIFO, scratch pad, etc.) can be created using Atmel's macro generator tool. They are organized by blocks of 32x4 bits. The ATF280E also embeds 8 global clocks, 4 high speed clocks, 8 LVDS Transmit channels, 8 LVDS Receive channels and a complete set of cold sparing programmable I/Os. The ATF280E I/Os are fully PCI-compliant.

The ATF280E is available in two space qualified packages. The MCGA472 package offers up to 324 I/Os for user application. The MQFP256 package is also proposed for application requiring less than 166 I/Os.

2. Pin Configuration

	Cirral	Table 2-1.	LEAD			LEAD	Cinnol	Olustar
LEAD	Signal	Cluster		Signal	Cluster		Signal	Cluster
A3	VDD	1	C7	IO/D2	12	E7	IO/FCK4	12
A4	VSS	1	C8	IO/CHECKN	12	E8	IO	12
A5	IO	12	C9	IO	12	E9	IO	12
A 6	VCC	12	C10	OLVDS6N	11	E10	VCC	12
A7	IO	12	C11	OLVDS6	11 E11		IO	12
A 8	VCC	12	C12	ILVDS5N	11 E12		REFEast	11
A9	IO	12	C13	ILVDS5	11	E13	IO	10
A10	IO/D3	12	C14	IO	10	E14	Ю	10
A11	VCCB	11	C15	VCC	10	E15	VCC	10
A12	IO	10	C16	IO	10	E16	IO/FCK3	10
A13	IO	10	C17	VCC	10	E17	IO/D5	10
A14	VCC	10	C18	IO	10	E18	IO/D6	10
A15	IO	10	C19	IO	10	E19	IO	9
A16	IO	10	C20	VSS	4	E20	IO	9
A17	IO	10	C21	VDD	5 E21 IO		IO	9
A18	VCC	10	C22	VDD	6	6 E22 IO		9
A19	VSS	1	D1	VSS	6	F1 VCC		1
A20	VDD	3	D2	IO/A2/CS1N	1	F2	IO	1
B2	VSS	3	D3	IO	1	F3	IO	1
B3	VDD	3	D4	VCC	12	F4	IO/A0	1
B4	VCC	12	D5	IO	12	F5	IO	1
B5	IO	12	D6	CCLK	12	F6	IO	12
B6	IO	12	D7	IO	12	F7	IO/GCK6/CSOUTN	12
B7	IO	12	D8	IO	12	F8	IO/D0	12
B 8	IO	12	D9	VCC	12	F9	IO	12
B9	IO	12	D10	IO	12	F10	IO	12
B10	OLVDS5N	11	D11	IO	12	F11	IO	12
B11	OLVDS5	11	D12	IO/D4	10	F12	VCC	10
B12	ILVDS6N	11	D13	VCC	10	F13	IO	10
B13	ILVDS6	11	D14	IO	10	F14	IO	10
B14	IO	10	D15	IO	10	F15	IO/D7	10
B15	IO/CS0	10	D16	IO	10	F16	DIODE	10
B16	VCC	10	D17	IO	10	F17	IO	9
B17	IO	10	D18	IO	10	F18	VCC	9
B18	IO	10	D19	VCC	9	F19	CON	9
B19	IO	10	D20	IO/D8	9	F20	VCC	9

Table 2-1. ATF280E MCGA472 pin assignment



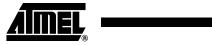


LEAD	Signal	Cluster	LEAD	Signal	Cluster	LEAD	Signal	Cluster
B20	VDD	4	D21	VCC	9	F21	IO/D9	9
B21	VSS	3	D22	VSS	6	F22	IO	9
C1	VDD	4	E1	VCC	1	G1	IO	1
C2	VDD	4	E2	IO	1	G2	VCC	1
C3	VSS	4	E3	IO	1	G3	IO	1
C4	IO	12	E4	IO	1	G4	IO/A3	1
C5	IO	12	E5	IO	1	G5	IO	1
C6	IO	12	E6	VCC	12	G6	IO/GCK7/A1	1

Table 2-2.	ATF280E MCGA472 pin assignment
	A THE LOOP MODE AND A PHIL ADDIGHTION

LEAD Signal Cluster LEAD Signal Cluster LEAD Signal Cluster G7 IO 12 J8 VCC 1 L9 IO 3 G8 VCC 12 J9 IO 1 L10 IO/A 1 G9 IO/D1 12 J10 IO 12 L11 IO 1 G10 IO 12 J11 IO 12 L12 IO 10 G11 VCC 12 J12 IO 10 L14 IO 9 G13 IO 10 J15 VCC 9 L16 IO 9 G15 IO 10 J16 IO 9 L17 IO 9 G16 IO 9 J17 IO 9 L18 IO 9 G16 IO 9 J21 IO/D11 9 L21 OLVDS4 8	LEAD	Signal	Cluster	LEAD	Signal	Cluster	LEAD	Signal	Cluster
G8 VCC 12 J9 IO 1 L10 IO/A6 1 G9 IO/D1 12 J10 IO 12 L11 IO 1 G10 IO 12 J11 IO 12 L12 IO 10 G11 VCC 12 J13 IO 10 J14 IO 9 G12 IO 10 J14 IO/GCK5 10 L15 VCC 9 G14 IO 10 J16 IO 9 L17 IO 9 G15 IO 10 J16 IO 9 L17 IO 9 G16 IO 9 J17 IO 9 L18 IO 9 G16 IO 9 J20 IO/D11 9 L21 OLVDS4 8 G20 IO 9 J21 IO 9 M1 IO 1 G21	-	-			-				
G9 IO/D1 12 J10 IO 12 L11 IO 1 G10 IO 12 J11 IO 12 L12 IO 10 G11 VCC 12 J12 IO 12 L13 IO 9 G12 IO 10 J13 IO 10 L14 IO 9 G13 IO 10 J14 IO/GCK5 10 L15 VCC 9 G13 IO 10 J15 VCC 9 L16 IO 9 G15 IO 10 J16 IO 9 L17 IO 9 G17 IO/GCK4 9 J18 IO 9 L19 IO 9 G16 IO 9 J20 IO/D11 9 L21 OLVDS3 8 G19 IO 9 J22 IO 9 M1 IO 1 10 <	-								
G10 IO 12 J11 IO 12 L12 IO 10 G11 VCC 12 J12 IO 12 L13 IO 9 G12 IO 10 J13 IO 10 L14 IO 9 G14 IO 10 J14 IO/GCK5 10 L15 VCC 9 G16 IO 9 J17 IO 9 L16 IO 9 G16 IO 9 J17 IO 9 L18 IO 9 G16 IO 9 J17 IO 9 L19 IO 9 G17 IO/GCK4 9 J18 IO 9 L20 OLVDS4 8 G19 IO 9 J20 IO/D11 9 L21 OLVDS3 8 G20 IO 9 K1 IO 1 M2 OLVDS7 2 <t< th=""><th>-</th><th></th><th></th><th></th><th></th><th></th><th></th><th></th><th></th></t<>	-								
G11 VCC 12 J12 IO 12 L13 IO 9 G12 IO 10 J13 IO 10 L14 IO 9 G13 IO 10 J14 IO/GCK5 10 L15 VCC 9 G15 IO 10 J15 VCC 9 L16 IO 9 G16 IO 9 J17 IO 9 L17 IO 9 G16 IO 9 J17 IO 9 L18 IO 9 G17 IO/GCK4 9 J18 IO 9 L19 OLVDS4 8 G20 IO 9 J22 IO 9 M1 IO 1 G21 IO 9 K1 IO 1 M2 OLVDS3 8 G22 IO 9 K1 IO 1 M2 OLVDS7 2 H1 <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th>									
G12 IO 10 J13 IO 10 L14 IO 9 G13 IO 10 J14 IO/GCK5 10 L15 VCC 9 G14 IO 10 J15 VCC 9 L16 IO 9 G16 IO 9 J17 IO 9 L17 IO 9 G16 IO 9 J17 IO 9 L18 IO 9 G17 IO/GCK4 9 J18 IO 9 L19 IO 9 G18 IO/D10 9 J20 IO/D11 9 L21 OLVDS3 8 G20 IO 9 J21 IO 9 M1 IO 1 IO 1 IO 1 IO 1 IO 1 IO 1 ID 1 IO 1 M2 OLVDS7 2 M4 VCCB 2 H3 IO <th>-</th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th>	-								
G13 IO 10 J14 IO/GCK5 10 L15 VCC 9 G14 IO 10 J15 VCC 9 L16 IO 9 G15 IO 10 J16 IO 9 L17 IO 9 G16 IO 9 J17 IO 9 L18 IO 9 G17 IO/GCK4 9 J18 IO 9 L19 IO 9 G18 IO/D10 9 J19 VCC 9 L20 OL/DS4 8 G19 IO 9 J20 IO/D11 9 L21 OL/DS3 8 G20 IO 9 J21 IO 9 M1 IO 1 10 1 10 1 IO 1 IO 1 IO 1 M2 OL/DS7 2 M4 VCCB 2 H3 IO 1 K3 IL/DS7	-								
G14 IO 10 J15 VCC 9 L16 IO 9 G15 IO 10 J16 IO 9 L17 IO 9 G16 IO 9 J17 IO 9 L18 IO 9 G17 IO/GCK4 9 J18 IO 9 L19 IO 9 G18 IO/D10 9 J19 VCC 9 L20 OLVDS4 8 G19 IO 9 J21 IO 9 L21 OLVDS3 8 G20 IO 9 J21 IO 9 M1 IO 1 G21 IO 9 K1 IO 1 M2 OLVDS7 2 H1 IO/A4 1 K2 ILVDS8 2 M3 OLVDS8 2 H2 IO 1 K4 VCC 1 M5 IO 3 H4 <th>-</th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th> <th></th>	-								
G15 IO 10 J16 IO 9 L17 IO 9 G16 IO 9 J17 IO 9 L18 IO 9 G17 IO/GCK4 9 J18 IO 9 L19 IO 9 G18 IO/D10 9 J19 VCC 9 L20 OLVDS4 8 G19 IO 9 J20 IO/D11 9 L21 OLVDS3 8 G20 IO 9 J21 IO 9 L21 OLVDS3 8 G21 IO 9 J22 IO 9 M1 IO 1 G22 IO 9 K1 IO 1 M2 OLVDS3 2 H1 IO/A4 1 K2 ILVDS8 2 M3 OLVDS8 2 H2 IO 1 K4 VCC 1 M5 IO 3 <th< th=""><th>-</th><th></th><th></th><th></th><th></th><th></th><th></th><th></th><th></th></th<>	-								
G16 IO 9 J17 IO 9 L18 IO 9 G17 IO/GCK4 9 J18 IO 9 L19 IO 9 G18 IO/D10 9 J19 VCC 9 L20 OLVDS4 8 G19 IO 9 J20 IO/D11 9 L21 OLVDS3 8 G20 IO 9 J21 IO 9 L12 IO 7 G21 IO 9 K1 IO 1 M2 OLVDS7 2 H1 IO/A4 1 K2 ILVDS8 2 M3 OLVDS8 2 H2 IO 1 K4 VCC 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H5 VCC 1 K6 VCC 1 M8 IO 3 H6	-								
G17 IO/GCK4 9 J18 IO 9 L19 IO 9 G18 IO/D10 9 J19 VCC 9 L20 OLVDS4 8 G19 IO 9 J20 IO/D11 9 L21 OLVDS3 8 G20 IO 9 J21 IO 9 L22 IO 7 G21 IO 9 J22 IO 9 M1 IO 1 G22 IO 9 K1 IO 1 M2 OLVDS7 2 H1 IO/A4 1 K2 ILVDS8 2 M4 VCCB 2 H3 IO 1 K3 ILVDS7 2 M4 VCCB 2 H3 IO 1 K5 IO 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H4	-								
G18 IO/D10 9 J19 VCC 9 L20 OLVDS4 8 G19 IO 9 J20 IO/D11 9 L21 OLVDS3 8 G20 IO 9 J21 IO 9 L22 IO 7 G21 IO 9 J22 IO 9 M1 IO 1 G22 IO 9 K1 IO 1 M2 OLVDS7 2 H1 IO/A4 1 K2 ILVDS8 2 M3 OLVDS7 2 H2 IO 1 K3 ILVDS7 2 M4 VCCB 2 H3 IO 1 K5 IO 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H4 IO 1 K6 VCC 1 M7 IO 3 H6	-								
G19 IO 9 J20 IO/D11 9 L21 OLVDS3 8 G20 IO 9 J21 IO 9 L22 IO 7 G21 IO 9 J22 IO 9 M1 IO 1 G22 IO 9 K1 IO 1 M2 OLVDS7 2 H1 IO/A4 1 K2 ILVDS8 2 M3 OLVDS8 2 H2 IO 1 K3 ILVDS7 2 M4 VCCB 2 H3 IO 1 K4 VCC 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H5 VCC 1 K6 VCC 1 M7 IO 3 H6 IO 1 K8 IO 1 M8 IO 3 H7 IO	-								
G20 IO 9 J21 IO 9 L22 IO 7 G21 IO 9 J22 IO 9 M1 IO 1 G22 IO 9 K1 IO 1 M2 OLVDS7 2 H1 IO/A4 1 K2 ILVDS8 2 M3 OLVDS8 2 H2 IO 1 K3 ILVDS7 2 M4 VCCB 2 H3 IO 1 K4 VCC 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H4 IO 1 K6 VCC 1 M7 IO 3 H4 IO 1 K7 IO 1 M8 IO 3 H5 VCC 1 K8 IO 1 M10 IO 3 H7 IO	-								
G21 IO 9 J22 IO 9 M1 IO 1 G22 IO 9 K1 IO 1 M2 OLVDS7 2 H1 IO/A4 1 K2 ILVDS8 2 M3 OLVDS8 2 H2 IO 1 K3 ILVDS7 2 M4 VCCB 2 H3 IO 1 K4 VCC 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H4 IO 1 K6 VCC 1 M7 IO 3 H5 VCC 1 K8 IO 1 M8 IO 3 H6 IO 1 K9 IO 1 M9 IO 3 H7 IO 1 K9 IO 1 M10 IO 3 H7 IO	G19	IO	9	J20	IO/D11	9	L21	OLVDS3	8
G22 IO 9 K1 IO 1 M2 OLVDS7 2 H1 IO/A4 1 K2 ILVDS8 2 M3 OLVDS8 2 H2 IO 1 K3 ILVDS7 2 M4 VCCB 2 H3 IO 1 K4 VCC 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H5 VCC 1 K6 VCC 1 M7 IO 3 H6 IO 1 K7 IO 1 M8 IO 3 H7 IO 1 K8 IO 1 M10 IO 3 H8 VCC	G20	IO		J21	IO	9	L22	IO	7
H1 IO/A4 1 K2 ILVDS8 2 M3 OLVDS8 2 H2 IO 1 K3 ILVDS7 2 M4 VCCB 2 H3 IO 1 K4 VCC 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H4 IO 1 K6 VCC 1 M7 IO 3 H5 VCC 1 K7 IO 1 M8 IO 3 H6 IO 1 K7 IO 1 M9 IO 3 H7 IO 1 K8 IO 1 M10 IO 3 H7 IO 12 K10 TCK 1 M11 IO 4 H10 IO <	G21	IO	9	J22	IO	9	M1	IO	1
H2 IO 1 K3 ILVDS7 2 M4 VCCB 2 H3 IO 1 K4 VCC 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H5 VCC 1 K6 VCC 1 M7 IO 3 H6 IO 1 K7 IO 1 M8 IO 3 H7 IO 1 K8 IO 1 M8 IO 3 H8 VCC 1 K9 IO 1 M10 IO 3 H9 VCC 12 K10 TCK 1 M11 IO 4 H10 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K12 IO 10 M13 IO 7 H12 IO	G22	IO	9	K1	IO	1	M2	OLVDS7	2
H3 IO 1 K4 VCC 1 M5 IO 3 H4 IO 1 K5 IO 1 M6 IO 3 H5 VCC 1 K6 VCC 1 M7 IO 3 H6 IO 1 K7 IO 1 M8 IO 3 H7 IO 1 K8 IO 1 M8 IO 3 H8 VCC 1 K9 IO 1 M9 IO 3 H9 VCC 12 K10 TCK 1 M11 IO 4 H10 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K12 IO 10 M13 IO 7 H11 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO <th>H1</th> <th>IO/A4</th> <th>1</th> <th>K2</th> <th>ILVDS8</th> <th>2</th> <th>M3</th> <th>OLVDS8</th> <th>2</th>	H1	IO/A4	1	K2	ILVDS8	2	M3	OLVDS8	2
H4 IO 1 K5 IO 1 M6 IO 3 H5 VCC 1 K6 VCC 1 M7 IO 3 H6 IO 1 K7 IO 1 M8 IO 3 H7 IO 1 K8 IO 1 M9 IO 3 H8 VCC 1 K9 IO 1 M9 IO 3 H9 VCC 12 K10 TCK 1 M11 IO 4 H10 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K12 IO 10 M13 IO 7 H11 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO 10 K15 IO 9 M16 IO/D13 7 H14 <td< th=""><th>H2</th><th>IO</th><th>1</th><th>K3</th><th>ILVDS7</th><th>2</th><th>M4</th><th>VCCB</th><th>2</th></td<>	H2	IO	1	K3	ILVDS7	2	M4	VCCB	2
H5 VCC 1 K6 VCC 1 M7 IO 3 H6 IO 1 K7 IO 1 M8 IO 3 H7 IO 1 K8 IO 1 M9 IO 3 H8 VCC 1 K9 IO 1 M10 IO 3 H9 VCC 12 K10 TCK 1 M11 IO 4 H10 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K12 IO 10 M13 IO 7 H11 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO 10 K14 IO 9 M15 VCCB 8 H14 VCC 10 K16 VCC 9 M17 IO 7 H16	H3	IO	1	K4	VCC	1	M5	IO	3
H6 IO 1 K7 IO 1 M8 IO 3 H7 IO 1 K8 IO 1 M9 IO 3 H8 VCC 1 K9 IO 1 M10 IO 3 H9 VCC 12 K10 TCK 1 M11 IO 4 H10 IO 12 K10 TCK 1 M12 IO/D14 7 H11 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO 10 K14 IO 9 M15 VCCB 8 H14 VCC 10 K16 VCC 9 M17 IO 7 H15 VCC 10 K16 VCC 9 M17 IO 7 H16 <th>H4</th> <th>IO</th> <th>1</th> <th>K5</th> <th>IO</th> <th>1</th> <th>M6</th> <th>IO</th> <th>3</th>	H4	IO	1	K5	IO	1	M6	IO	3
H7 IO 1 K8 IO 1 M9 IO 3 H8 VCC 1 K9 IO 1 M10 IO 3 H9 VCC 12 K10 TCK 1 M11 IO 4 H10 IO 12 K10 TCK 1 M11 IO 4 H10 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K12 IO 10 M13 IO 7 H12 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO 10 K14 IO 9 M15 VCCB 8 H14 VCC 10 K16 VCC 9 M17 IO 7 H15 VCC 10 K16 VCC 9 M17 IO 7 H16 <th>H5</th> <th>VCC</th> <th>1</th> <th>K6</th> <th>VCC</th> <th>1</th> <th>M7</th> <th>IO</th> <th>3</th>	H5	VCC	1	K6	VCC	1	M7	IO	3
H8 VCC 1 K9 IO 1 M10 IO 3 H9 VCC 12 K10 TCK 1 M11 IO 4 H10 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K12 IO 10 M13 IO 7 H12 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO 10 K14 IO 9 M15 VCCB 8 H14 VCC 10 K15 IO 9 M16 IO/D13 7 H15 VCC 10 K16 VCC 9 M17 IO 7 H16 VCC 9 K17 IO 9 M18 REFSouth 8	H6	IO	1	K7	IO	1	M8	IO	3
H9 VCC 12 K10 TCK 1 M11 IO 4 H10 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K12 IO 10 M13 IO 7 H11 IO 12 K12 IO 10 M13 IO 7 H12 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO 10 K14 IO 9 M15 VCCB 8 H14 VCC 10 K15 IO 9 M16 IO/D13 7 H15 VCC 10 K16 VCC 9 M17 IO 7 H16 VCC 9 K17 IO 9 M18 REFSouth 8 H17 IO 9 K18 VCC 9 M19 VCC 7	H7	IO	1	K8	IO	1	M9	IO	3
H10 IO 12 K11 IO 12 M12 IO/D14 7 H11 IO 12 K12 IO 10 M13 IO 7 H12 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO 10 K14 IO 9 M15 VCCB 8 H14 VCC 10 K15 IO 9 M16 IO/D13 7 H14 VCC 10 K16 VCC 9 M17 IO 7 H14 VCC 10 K16 VCC 9 M16 IO/D13 7 H15 VCC 10 K16 VCC 9 M17 IO 7 H16 VCC 9 K17 IO 9 M18 REFSouth 8 H17 IO 9 K18 VCC 9 M19 VCC 7 <	H8	VCC	1	K9	IO	1	M10	IO	3
H11 IO 12 K12 IO 10 M13 IO 7 H12 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO 10 K14 IO 9 M15 VCCB 8 H14 VCC 10 K15 IO 9 M16 IO/D13 7 H14 VCC 10 K16 VCC 9 M17 IO 7 H15 VCC 10 K16 VCC 9 M17 IO 7 H16 VCC 9 K17 IO 9 M18 REFSouth 8 H17 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K19 IO 9 M20 ILVDS3N 8 H19 IO 9 K20 OLVDS3N 8 M22 IO 7	H9	VCC	12	K10	ТСК	1	M11	IO	4
H12 IO 12 K13 RESETN 10 M14 IO/D12 9 H13 IO 10 K14 IO 9 M15 VCCB 8 H14 VCC 10 K15 IO 9 M16 IO/D12 9 H14 VCC 10 K15 IO 9 M16 IO/D13 7 H15 VCC 10 K16 VCC 9 M17 IO 7 H16 VCC 9 K17 IO 9 M18 REFSouth 8 H17 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K19 IO 9 M20 ILVDS3N 8 H19 IO 9 K20 OLVDS4N 8 M21 ILVDS4N 8 H20 IO 9 K22 IO 9 N1 IO 3 <th>H10</th> <th>IO</th> <th>12</th> <th>K11</th> <th>IO</th> <th>12</th> <th>M12</th> <th>IO/D14</th> <th>7</th>	H10	IO	12	K11	IO	12	M12	IO/D14	7
H13 IO 10 K14 IO 9 M15 VCCB 8 H14 VCC 10 K15 IO 9 M16 IO/D13 7 H15 VCC 10 K16 VCC 9 M17 IO 7 H16 VCC 9 K17 IO 9 M18 REFSouth 8 H17 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K19 IO 9 M20 ILVDS3N 8 H19 IO 9 K20 OLVDS4N 8 M21 ILVDS4N 8 H20 IO 9 K21 OLVDS3N 8 M22 IO 7 H21 IO 9 K22 IO 9 N1 IO 3	H11	IO	12	K12	IO	10	M13	IO	7
H14 VCC 10 K15 IO 9 M16 IO/D13 7 H15 VCC 10 K16 VCC 9 M17 IO 7 H16 VCC 9 K17 IO 9 M18 REFSouth 8 H17 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K19 IO 9 M20 ILVDS3N 8 H19 IO 9 K20 OLVDS4N 8 M21 ILVDS4N 8 H20 IO 9 K22 IO 9 N1 IO 3	H12	IO	12	K13	RESETN	10	M14	IO/D12	9
H15 VCC 10 K16 VCC 9 M17 IO 7 H16 VCC 9 K17 IO 9 M18 REFSouth 8 H17 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K19 IO 9 M20 ILVDS3N 8 H19 IO 9 K20 OLVDS4N 8 M21 ILVDS4N 8 H20 IO 9 K21 OLVDS3N 8 M22 IO 7 H21 IO 9 K22 IO 9 N1 IO 3	H13	IO	10	K14	IO	9	M15	VCCB	8
H16 VCC 9 K17 IO 9 M18 REFSouth 8 H17 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K19 IO 9 M20 ILVDS3N 8 H19 IO 9 K20 OLVDS4N 8 M21 ILVDS4N 8 H20 IO 9 K21 OLVDS3N 8 M22 IO 7 H21 IO 9 K22 IO 9 N1 IO 3	H14	VCC	10	K15	IO	9	M16	IO/D13	7
H17 IO 9 K18 VCC 9 M19 VCC 7 H18 IO 9 K19 IO 9 M20 ILVDS3N 8 H19 IO 9 K20 OLVDS4N 8 M21 ILVDS4N 8 H20 IO 9 K21 OLVDS3N 8 M22 IO 7 H21 IO 9 K22 IO 9 N1 IO 3	H15	VCC	10	K16	VCC	9	M17	IO	7
H18 IO 9 K19 IO 9 M20 ILVDS3N 8 H19 IO 9 K20 OLVDS4N 8 M21 ILVDS4N 8 H20 IO 9 K21 OLVDS3N 8 M22 IO 7 H21 IO 9 K22 IO 9 N1 IO 3	H16	VCC	9	K17	IO	9	M18	REFSouth	8
H19 IO 9 K20 OLVDS4N 8 M21 ILVDS4N 8 H20 IO 9 K21 OLVDS3N 8 M22 IO 7 H21 IO 9 K22 IO 9 N1 IO 3	H17	IO	9	K18	VCC	9	M19	VCC	7
H20 IO 9 K21 OLVDS3N 8 M22 IO 7 H21 IO 9 K22 IO 9 N1 IO 3	H18	IO	9	K19	IO	9	M20	ILVDS3N	8
H21 IO 9 K22 IO 9 N1 IO 3	H19	IO	9	K20	OLVDS4N	8	M21	ILVDS4N	8
	H20	IO	9	K21	OLVDS3N	8	M22	IO	7
H22 IO 9 L1 IO/A7 1 N2 OLVDS7N 2	H21	IO	9	K22	IO	9	N1	IO	3
	H22	IO	9	L1	IO/A7	1	N2	OLVDS7N	2





LEAD	Signal	Cluster	LEAD	Signal	Cluster	LEAD	Signal	Cluster
J1	IO	1	L2	ILVDS8N	2	N3	OLVDS8N	2
J2	IO	1	L3	ILVDS7N	2	N4	IO	3
J3	IO	1	L4	VCC	1	N5	IO/A9	3
J4	IO/A5	1	L5	REFNorth	2	N6	IO	3
J5	Ю	1	L6	IO	1	N7	VCC	3
J6	VCC	1	L7	IO	1	N8	IO/A12	3
J7	IO	1	L8	IO/A8	3	N9	IO	3

Cluster

4

4

6

6

6

6

6

6

7

7

7

7

7

3

3

3

3

4

4

4

4

4

4

5

6

6

6

6

6

6

7

7

7

7

7

7

3

3

Signal

VCC

10

IO

Ю

10

10

IO/GCK2

IO

10

Ю

10

IO/D15

VCC

IO

IO

IO

10

10

Ю

IO/A19

VCC

VCC

IO

REFWest

IO

10

VCC

IO

IO/A22

VCC

Ю

IO

Ю

IO

VCC

VSS

VCC

IO

LEAD

U10

U11

U12

U13

U14

U15

U16

U17

U18

U19

U20

U21

U22

V1

V2

V3

V4

V5

V6

٧7

V8

٧9

V10

V11

V12

V13

V14

V15

V16

V17

V18

V19

V20

V21

V22

W1

W2

W3

Cluster

4

5

6

6

6

7

7

7

7

7

7

7

7

3

3

3

3

3

3

3

4

4

4

4

6

6

6

6

6

7

7

7

7

7

7

3

3

3

U1	IO	
U2	IO	
U3	VCC	

Table 2-3. ATF280E MCGA472 pin assignment

Signal

IO

VCCB

VCC

Ю

VCC

VCC

IO

IO

VCC

IO

10

10

IO

IO/A11

10

IO

10

10

TDO

IO/A14

IO

Ю

IO

IO/A20

Ю

VCC

IO

VCC

IO

M2

IO/INIT

IO

Ю

VCC

10

LEAD

R10

R11

R12

R13

R14

R15

R16

R17

R18

R19

R20

R21

R22

T1

T2

ΤЗ

Τ4

T5

Т6

T7

Т8

Т9

T10

T11

T12

T13

T14

T15

T16

T17

T18

T19

T20

T21

T22



7750A-AERO-07/07

LEAD

N10

N11

N12

N13

N14

N15

N16

N17

N18

N19

N20

N21

N22

P1

P2

P3

P4

P5

P6

P7

P8

P9

P10

P11

P12

P13

P14

P15

P16

P17

P18

P19

P20

P21

P22

R1

R2

R3

Signal

TMS

10

IO

M1

10

10

Ю

VCC

IO

VCC

ILVDS3

ILVDS4

Ю

VCC

10

Ю

VCC

VCC

Ю

IO/A13

VCC

IO/GCK1/A16

10

10

Ю

10

IO/GCK3

VCC

IO

VCC

Ю

IO

Ю

IO

IO

IO

Ю

10

Cluster

4

4

6

7

7

7

7

7

7

7

8

8

7

3

3

3

3

3

3

3

3

4

4

6

6

6

7

7

7

7

7

7

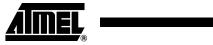
7

7

7

3

3



LEAD	Signal	Cluster	LEAD	Signal	Cluster	LEAD	Signal	Cluster
R4	IO	3	U4	TDI	3	W4	VCC	3
R5	IO/A10	3	U5	VCC	3	W5	IO	4
R6	IO	3	U6	IO/GCK8/A15	3	W6	IO	4
R7	VCC	3	U7	TRST	4	W7	IO	4
R8	VCC	4	U8	IO	4	W8	IO	4
R9	VCC	4	U9	VCC	4	W9	IO	4

 Table 2-4.
 ATF280E MCGA472 pin assignment

LEAD	Signal	Cluster	LEAD	Signal	Cluster
W10	IO	4	AA4	IO/A17	4
W11	VCC	4	AA5	IO	4
W12	IO	6	AA6	IO/A18	4
W13	IO	6	AA7	VCC	4
W14	VCC	6	AA8	IO	4
W15	IO	6	AA9	IO	4
W16	IO	6	AA10	ILVDS2	5
W17	MO	6	AA11	ILVDS2N	5
W18	IO	6	AA12	OLVDS1	5
W19	VCC	6	AA13	OLVDS1N	5
W20	IO	7	AA14	IO	6
W21	IO/LDC	7	AA15	IO	6
W22	VSS	7	AA16	IO	6
Y1	VDD	7	AA17	IO/A23	6
Y2	VDD	7	AA18	IO	6
Y3	VSS	9	AA19	VCC	6
Y4	IO	4	AA20	VDD	10
Y5	IO	4	AA21	VSS	10
Y6	IO	4	AB3	VDD	12
¥7	IO	4	AB4	VSS	12
Y8	IO	4	AB5	VCC	4
Y9	IO	4	AB6	VCC	4
Y10	ILVDS1	5	AB7	IO	4
Y11	ILVDS1N	5	AB8	IO/FCK1	4
Y12	OLVDS2	5	AB9	IO	4
Y13	OLVDS2N	5	AB10	IO	4
Y14	IO	6	AB11	IO	4
Y15	IO	6	AB12	IO/A21	6
Y16	IO	6	AB13	IO	6
Y17	VCC	6	AB14	IO	6
Y18	IO	6	AB15	IO	6
Y19	IO/OTSN	6	AB16	IO/FCK2	6
Y20	VSS	9	AB17	IO	6
Y21	VDD	7	AB18	IO	6
Y22	VDD	9	AB19	VSS	12
AA2	VSS	10	AB20	VDD	12
AA3	VDD	9			İ.





3. Pin Description

Clock

GCK1:GCK8 - Global Clock (Input)

FCK1:FCK4 - Fast Clock (Input)

I/O

I/Oy_x - Programmable I/O (Input/Output)

The programmable I/Os are dedicated to user's application. Each programmable I/O can independently be configured as input, output or bidirectional I/O. Each I/O is part of an I/O cluster.

This leads to the following naming: I/Oy_x where 'y' is the cluster number (1 < y < 8) and 'x' is the I/O number in the cluster.

OLVDSx - LVDS Driver (Output)

OLVDSx where 'x' is the LVDS channel number (1 < x < 8).

OLVDSxN - Complimentary LVDS Driver (Output)

OLVDSxN where 'x' is the LVDS channel number (1 < x < 8).

ILVDSx - LVDS Receiver (Input)

ILVDSx where 'x' is the LVDS channel number (1 < x < 8).

ILVDSxN - Complimentary LVDS Receiver(Input)

ILVDSxN where 'x' is the LVDS channel number (1 < x < 8).

FPGA Configuration

M0, M1, M2 (Input)

The mode pins are dedicated TTL threshold inputs that determine the configuration mode to be used. Table 1 lists the states for each configuration mode. The mode pins should not be changed during power-on-reset, manual reset, or configuration download. The user may change the mode pins during configuration idle. These pins have no pull-up resistors to VCC, so they need to be driven by the user or tied off.

CCLK (Input/Output)

CCLK is the configuration clock pin. It is an input or output depending on the mode of operation. During power-on-reset or manual reset, it is a tri-stated output. During configuration download and in Mode 0, it is an output with a typical frequency of 1 MHz. During configuration download and in all other modes, it is a Schmitt trigger input with approximately 1V of hysteresis for noise immunity. It is an input during configuration idle, but is ignored. It is pulled to VCC with a nominal 50K internal resistor.

RESETn - Reset (Input)

RESETn is the FPGA configuration manual reset pin. It is available during all configuration states. It initiates a configuration clear cycle and, if operating in Mode 0, an auto configuration. It is a dedicated Schmitt trigger input with approximately 1V of hysteresis for noise immunity. It is pulled to VCC with a nominal 50K internal resistor.

INIT - (Input/Output)

INIT is a multi-function pin. During power-on-reset and manual reset, the pin functions as an open drain bi-directional I/O which releases High when the configuration clear cycle is complete, but can be held Low to hold the configuration in a reset state. Once released, the FPGA will proceed to either configuration download or idle, as appropriate. During configuration download, the INIT pin is again an open drain bi-directional pin which signals if an error is encountered during the download of a configuration bitstream. In addition, during the Check Function, the INIT pin drives Low for any configuration SRAM mismatch (see the description of the Check Function on page 16 for more details). While in open drain mode, the pin is pulled to VDD with a nominal 20K internal resistor. When not configuring, the INIT pin becomes a fully functional user I/O.

CON - Configuration Status (Input/Output)

CON is the FPGA configuration start and status pin. It is a dedicated open drain bi-directional pin. During power-on-reset or manual reset, CON is driven Low by the FPGA. In Modes 2, 6, or 7, when the FPGA has finished the configuration clear cycle, CON is released to indicate the device is ready for the user to initiate configuration download. The user may then drive CON Low to initiate a configuration download. After three clock cycles, CON is then driven Low by the FPGA until it finishes the download, and it is then released. In Mode 0, CON is not released by the FPGA at the end of power-on-reset or manual reset. Instead, CON is controlled by the FPGA until the end of the auto-configuration process. CON is released at the end of configuration download in Mode 0, and the user may then initiate a manual configuration download by driving CON Low. While in open drain mode, the pin is pulled to VDD with a nominal 10K internal resistor.

HDC - High During Configuration (output)

HDC(1) is driven High by the FPGA during power-on-reset, manual reset, and configuration download. During normal operation, the pin is a fully functional user I/O.

Note: 1. All user I/O default to inputs with pull-ups "on". The HDC pin transitions from driving a strong "1" to a pull-up "1" after reset. The HDC pin will transition from driving a strong "1" to the user programmed state at the end of configuration download. If not programmed, the default state is input with pull-up.

LDC - Low During Configuration (output)

HDC(1) is driven Low by the FPGA during power-on-reset, manual reset, and configuration download. During normal operation, the pin is a fully functional user I/O.

Note: 1. All user I/O default to inputs with pull-ups "on". The HDC pin transitions from driving a strong "1" to a pull-up "1" after reset. The HDC pin will transition from driving a strong "1" to the user programmed state at the end of configuration download. If not programmed, the default state is input with pull-up.

D0 - Configuration Data Bus - LSB (Input/Output)

D0 is the lsb of the FPGA configuration data bus used to download configuration data to the device. During power-on-reset or manual reset, D0 is controlled by the configuration SRAM. The D0 pin will transition from the user programmed state to a CMOS input with a nominal 20K internal pull-up resistor as the SRAM at that location is cleared by the configuration clear cycle. D0 becomes an input during configuration download.

D1:D15 - Configuration Data Bus - Upper bits (Input/Output)

D1:D15 are the upper bits of the 8/16-bit parallel data bus used to download configuration data to the device. During power-on-reset or manual reset, D1:D15 are controlled by the configura-





tion SRAM. The D1:D15 pins will transition from the user programmed state to CMOS inputs with nominal 20K internal pull-up resistors as the SRAM at those locations is cleared by the configuration clear cycle.

When in Modes 2 or 6, D1:D7 become inputs during configuration download. D1:D7 are not used in the serial Modes 0, 1 and 7.

When in Modes 2 or 6, D8:D15 become optional inputs during configuration download. They become available as soon as the appropriate bit in the configuration control register is set. D8:D15 are not used in the serial Modes 0, 1 and 7.

A0:A19 - Configuration Address Bus (Input/Output)

A0:A19(1) are used to control external addressing of memories during downloads. During power-on-reset or manual reset, A0:A19 are controlled by the configuration SRAM. The A0:A19 pins will transition from the user programmed state to CMOS inputs with nominal 20K internal pull-up resistors as the SRAM at those locations is cleared by the configuration clear cycle. When in Mode 6, A0:A19 become outputs during configuration download. A0:A19 are used only in Mode 6.

Note: 1. Pin A2 is also pin CS1, which is available only for Mode 2. See the description for CS1 on page 5 for more details.

CS0/CS1 - Configuration Chip Select (Input/Output)

CS0 is an FPGA configuration chip select. It is active Low. During power-on-reset or manual reset, CS0 is controlled by the configuration SRAM. The CS0 pin will transition from the user programmed state to a CMOS input with a nominal 20K internal pull-up resistor as the SRAM at that location is cleared by the configuration clear cycle. In Mode 1, it is used as a chip select to enable configuration to begin. It is most often used as the chip select of the downstream device in a cascade chain, and is usually driven by CSOUT of the upstream device. Releasing CS0 during configuration causes the Mode 1 FPGA to abort the download and release CON.

CS0 is used only in Mode 1. CS1 is used only in Mode 2

Note: 1. Pin CS1 is also pin A2, which is active only for Mode 6. See the description for A0:A19, on page 5 for more details.

CSOUT - Configuration Cascade Output (Output)

CSOUT is the configuration pin used to enable the downstream device in a cascade chain. During power-on-reset or manual reset, CSOUT is controlled by the configuration SRAM. The CSOUT pin will transition from the user programmed state to a CMOS input with a nominal 20K internal pull-up resistor as the SRAM at that location is cleared by the configuration clear cycle. During configuration download, CSOUT becomes an optional output. It is enabled by default after reset, and may be enabled or disabled via the configuration control register. If the user has disabled the cascade function, the pin remains a user I/O. If the cascade function is enabled, the CSOUT pin is driven High at the start of configuration download. At the end of the device's portion of the cascade bitstream, the CSOUT pin is driven Low (and into the CS0 or CS1 of the downstream device) to enable the downstream device. CSOUT is released by the device at the end of the cascade bitstream and becomes a fully functional user I/O.

CHECK - Configuration Check (Input/Output)

CHECK is a configuration control pin used to control the Check Function. The Check Function takes a bitstream and compares it to the contents of a previously loaded bitstream and notifies the user of any differences. Any differences causes the INIT pin to go Low. During power-on-

reset or manual reset, CHECK is controlled by the configuration SRAM. The CHECK pin will transition from the user programmed state to a CMOS input with a nominal 20K internal pull-up resistor as the SRAM at that location is cleared by the configuration clear cycle. During configuration download, CHECK becomes an optional input. It is enabled by default after reset, and may be enabled or disabled via the configuration control register. If the user has disabled the Check Function, the pin remains a user I/O.

OTS - Dual Use Tri State (Input)

OTS is an input pin used to immediately tri-state all user I/O. It is enabled by a bit in the configuration control register. Once activated, it is always an input. The OTS tri-state control of Dual-use pins is superseded by the configuration logic's claim on those pins. If the user has disabled the OTS function, the pin remains as User I/O.

JTAG

TCK - Test Clock (input)

Used to clock serial data into boundary scan latches and control sequence of the test

state machine. TCK can be asynchronous with CLK.

TMS - Test Mode select (input)

Primary control signal for the state machine. Synchronous with TCK. A sequence of values on TMS adjusts the current state of the TAP.

TDI - Test data input (input)

Serial input data to the boundary scan latches. Synchronous with TCK

TDO - Test data output (output)

Serial output data from the boundary scan latches. Synchronous with TCK

TRST - Test Reset (input)

Resets the test state machine. Can be asynchronous with TCK. Shall be grounded for end application.

Power Supply

VDD - Core Power Supply

VDD is the power supply input for the ATF280E core. $VDD = 1.8V \pm 0.2V$

VCCy - I/O Power Supply

VCC is the power supply input for the programmable I/Os. Each I/O cluster has dedicated VCCy sources where 'y' is the cluster number (1 < y < 8). VCC can be independently configured to either 1.8V \pm 0.2V or 3.3V \pm 0.3V for each cluster.

VCCB - LVDS I/O Power Supply

VCCB is the power supply input for the LVDS I/Os. Each pair of LVDS channels has a dedicated VCCB sources. VCCB = $3.3V \pm 0.3V$

VREF - LVDS reference voltage

VREF is the reference voltage for LVDS buffer operations. Each LVDS cluster has dedicated VREF source. VREF = $1.25V \pm 0.1V$

VSS - Ground





4. ATF280E FPGA Architecture

4.1 The Symmetrical Array

At the heart of the Atmel ATF280E architecture is a symmetrical array of identical cells. The array is continuous from one edge to the other, except for bus repeaters spaced every four cells. At the intersection of each repeater row and column is a 32 x 4 RAM block accessible by adjacent buses. The RAM can be configured as either a single-ported or dual-ported RAM (1), with either synchronous or asynchronous operation

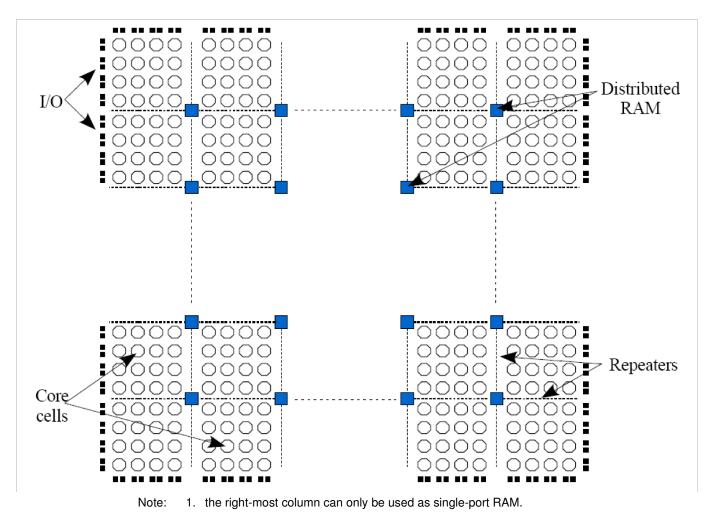
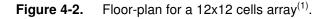
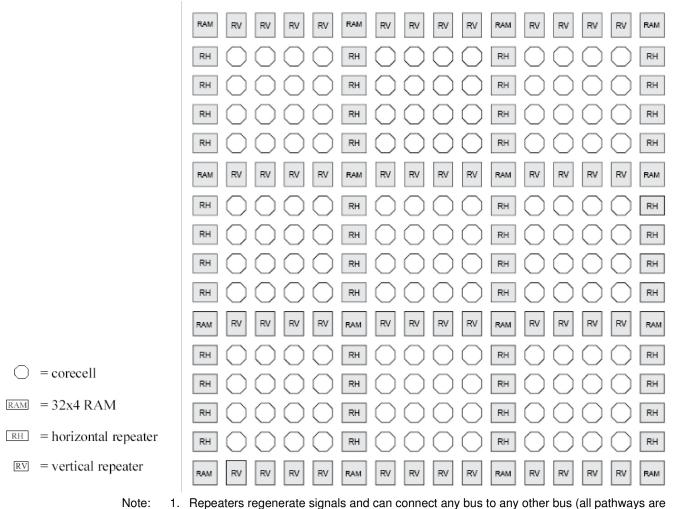


Figure 4-1. Core device overview





 Repeaters regenerate signals and can connect any bus to any other bus (all pathways are legal) on the same plane. Each repeater has connections to two adjacent local-bus segments and two express-bus segments. This is done automatically using the integrated development system (IDS) tool.





4.2 The Core Cell

The following figure depicts the ATF280E cell which is a highly configurable logic block based around two 3-input LUTs (8 x 1 ROM), and which can be combined to produce one 4-input LUT. This means that any cell can implement two functions of 3 inputs or one function of 4 inputs.

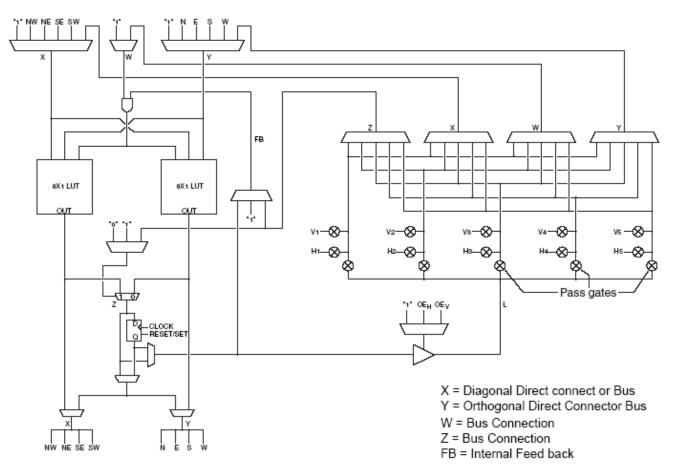


Figure 4-3. ATF280E Core Cell

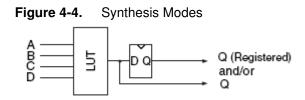
Every cell includes a register element, a D-type flip-flop, with programmable clock and reset polarities. The initialization of the register is also programmable. It can be either SET or RESET. The flip-flop can be used to register the output of one of the LUT. It can also be exploited in conjunction with the feedback path element to implement a complete ripple counter stage in a single cell. The registered or unregistered output of each LUT can be feedback within the cell and treated as another input (Feedback signal in Figure 3). This allows, for example, a single counter stage to be implemented within one cell without using external routing resources for the feedback connection.

There is also a 2-to-1 multiplexer in every cell, and an upstream AND gate in the "front end" of the cell. This AND gate is an important feature in the implementation of efficient array multipliers as the product and carry terms can both be generated within a single logic cell.

The cell flexibility makes the ATF280E architecture well suited for most of the digital design application areas.

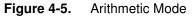
4.2.1 Synthesis Mode

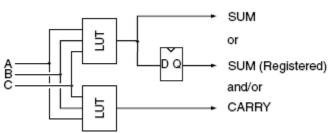
This mode is particularly important for the use of VHDL design. VHDL Synthesis tools generally will produce as their output large amounts of random logic functions. Having a 4-input LUT structure gives efficient random logic optimization without the delays associated with larger LUT structures. The output of any cell may be registered, tri-stated and/or fed back into a core cell.



4.2.2 Arithmetic Mode

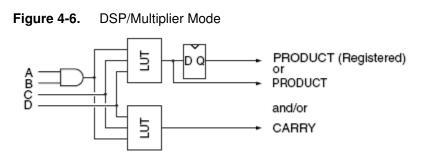
This mode is frequently used in many designs. As can be seen in the figure, the ATF280E core cell can implement a 1-bit full adder (2-input adder with both Carry In and Carry Out) in one core cell. Note that the sum output in this diagram is registered. This output could then be tri-stated and/or fed back into the cell.





4.2.3 DSP/Multiplier Mode

This mode is used to efficiently implement array multipliers. An array multiplier is an array of bitwise multipliers, each implemented as a full adder with an upstream AND gate. Using this AND gate and the diagonal interconnects between cells, the array multiplier structure fits very well into the ATF280E architecture.



4.2.4 Counter Mode

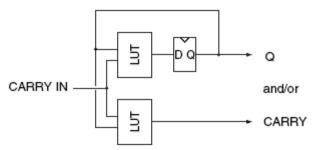
Counters are fundamental to almost all digital designs. They are the basis of state machines, timing chains and clock dividers. A counter is essentially an increment by one function (i.e., an adder), with the input being an output (or a decode of an output) from the previous stage. A 1-bit





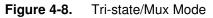
counter can be implemented in one core cell. Again, the output can be registered, tri-stated and/or fed back.

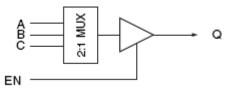
Figure 4-7. Counter Mode



4.2.5 Tri-state/Mux Mode

This mode is used in many telecommunications applications, where data needs to be routed through more than one possible path. The output of the core cell is very often tri-statable for many inputs to many outputs data switching.





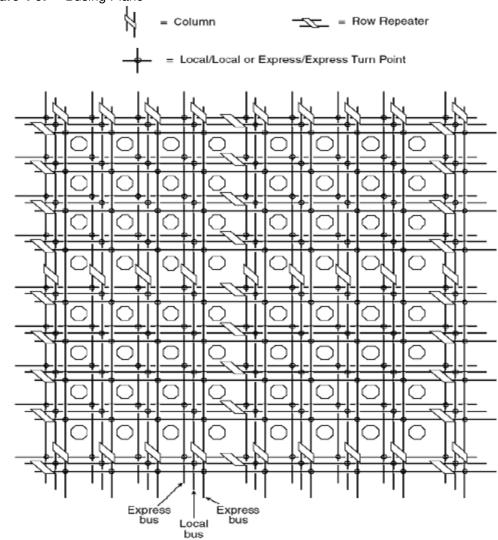
ATF280E

4.3 The Busing Network

The following figure depicts one of five identical busing planes. Each plane has three bus resources:

- a local-bus resource (the middle bus)
- two express-bus (both sides) resources

Figure 4-9. Busing Plane



The bus resources are connected via repeaters. Each repeater has connections to two adjacent local-bus segments and two express-bus segments.

Each local-bus segment spans four cells and connects to consecutive repeaters. Each expressbus segment spans eight cells and "leapfrogs" or bypasses a repeater. Repeaters regenerate signals and can connect any bus to any other bus (all pathways are legal) on the same plane.





Although not shown, a local bus can bypass a repeater via a programmable pass gate allowing long on-chip tri-state buses to be created. Local/Local turns are implemented through pass gates in the cell-bus interface (see following page).

Express/Express turns are implemented through separate pass gates distributed throughout the array.

4.3.1 Dual Function Bus Resource

Some of the bus resource on the ATF280E are used as a dual-function resource. The table hereafter shows which buses are used in a dual-function mode and which bus plane is used.

Function	Туре	Plane(s)	Direction	Comments
Cell Output Enable	Local	5	Horizontal and Vertical	
RAM Output Enable	Express	2	Vertical	Bus full length at array edge Bus in first column to left of RAM block
RAM Write Enable	Express	1	Vertical	Bus full length at array edge Bus in first column to left of RAM block
RAM Address	Express	1 - 5	Vertical	Buses full length at array edge Buses in second column to left of RAM block
RAM Data In	Local	1	Horizontal	
RAM Data Out	Local	2	Horizontal	
Clocking	Express	4	Vertical	Bus half length at array edge
Set/Reset	Express	5	Vertical	Bus half length at array edge

Table 4-1.Dual-function Buses

The ATF280E software tools are designed to accommodate dual-function buses in an efficient manner

4.4 Cell Connections

The following figure presents the direct connections between a cell and its eight nearest neighbors. It also summarizes the connections between a cell and five horizontal local buses (1 per busing plane) and five vertical local buses (1 per busing plane).

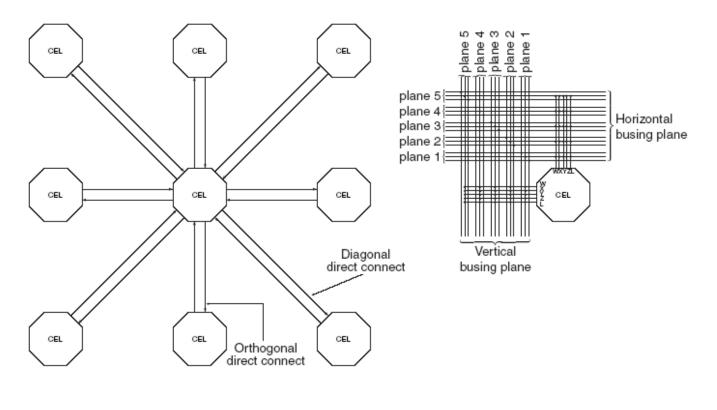


Figure 4-10. Cell Connections

(a) Cell-to-cell Connections

(b) Cell-to-bus Connections





5. FreeRAM[™]

The ATF280E offers 115Kbits of dual-port RAM called FreeRAMTM. The FreeRAMTM is made of 32 x 4 dual-ported RAM blocks and dispersed throughout the array as shown in the figure hereafter. This FreeRAMTM is SEU hardened.

A 4-bit Input Data Bus connects to four horizontal local buses distributed over four sector rows (plane 1). A 4-bit Output Data Bus connects to four horizontal local buses distributed over four sector rows (plane 2). A 5-bit Input Address Bus connects to five vertical express buses in same column. A 5-bit Output Address Bus connects to five vertical express buses in same column. A in (input address) and Aout (output address) alternate positions in horizontally aligned RAM blocks. For the left-most RAM blocks, Aout is on the left and Ain is on the right. For the right-most RAM blocks, Ain is on the left and Aout is tied off, thus it can only be configured as a single port. For single-ported RAM, Ain is the READ/WRITE address port and Din is the (bi-directional) data port.

Right-most RAM blocks can be used only for single-ported memories. WEN and OEN connect to the vertical express buses in the same column.

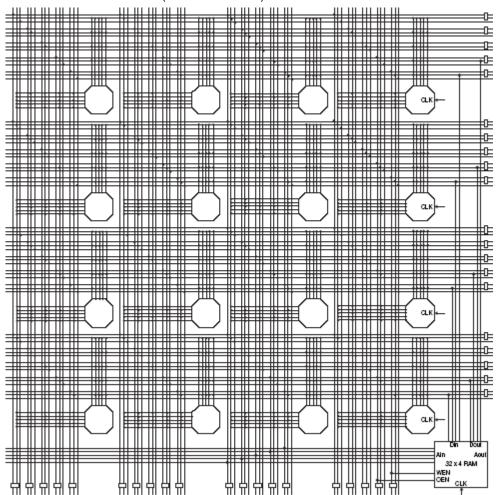


Figure 5-1. RAM Connections (One RAM Block)

²² **ATF280E**

Reading and writing of the 10ns 32 x 4 dual-port FreeRAM are independent of each other. Reading the 32 x 4 dual-port RAM is completely asynchronous.

Latches on Write Address, Write Enable and Data In are transparent: when Load is logic 1, data flows through, when Load is logic 0, data is latched. These latches are used to synchronize Write Address, Write Enable Not, and Din signals for a synchronous RAM.

Each bit in the 32 x 4 dual-port RAM is also a transparent latch. The front-end latch and the memory latch together form an edge-triggered flip flop. When a nibble is (Write) addressed and LOAD is logic 1 and WE is logic 0, data flows through the bit. When a nibble is not (Write) addressed or LOAD is logic 0 or WE is logic 1, data is latched in the nibble.

The two CLOCK muxes are controlled together; they both select CLOCK (for a synchronous RAM) or they both select "1" (for an asynchronous RAM). CLOCK is obtained from the clock for the sector-column immediately to the left and immediately above the RAM block.

Writing any value to the RAM clear byte during configuration clears the RAM (see the *"AT40K/40KAL Configuration Series"* application note at www.atmel.com).

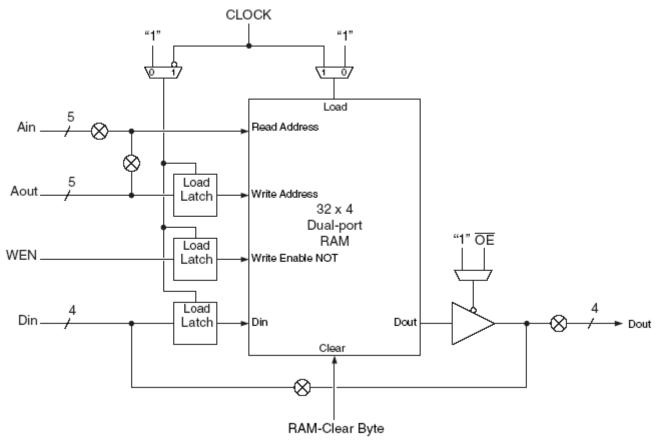
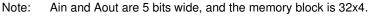


Figure 5-2. RAM Logic



Here is an example of a RAM macro constructed using ATF280E's FreeRAM cells. The macro shown is a 128 x 8 dual-ported asynchronous RAM. Note the very small amount of external logic required to complete the address decoding for the macro. Most of the logic cells in the sectors





occupied by the RAM will be unused: they can be used for other logic in the design. This logic can be automatically generated using the macro generators.

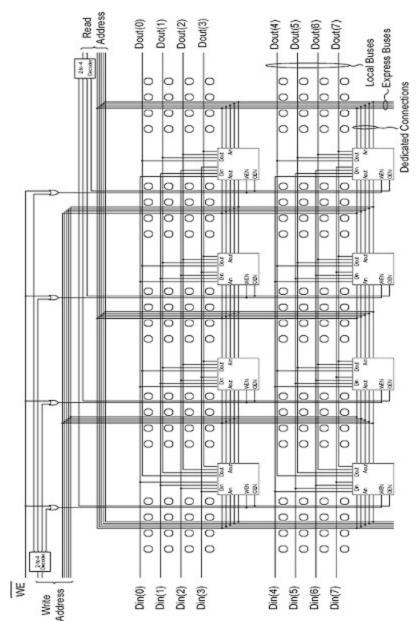


Figure 5-3. RAM Example: 128 x 8 Dual-ported RAM (Asynchronous)

6. Clocking Scheme

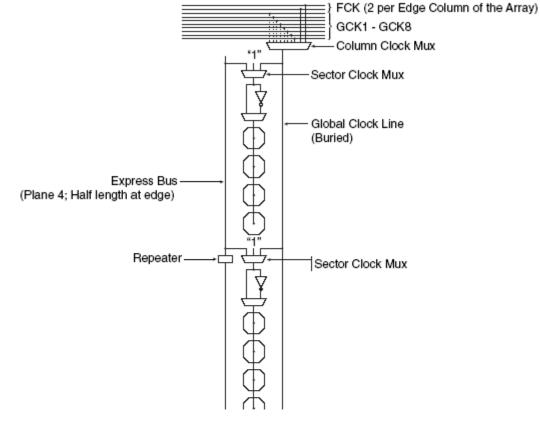
The entire ATF280E clocking scheme (including clock trees and muxes) is SET hardened.

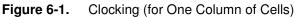
There are eight differential Global Clock buses (GCK1 - GCK8) on the ATF280E FPGA. In addition to the eight Global Clocks, there are four Fast Clocks (FCK1 - FCK4).

Each column of an array has a "Column Clock mux" and a "Sector Clock mux". The Column Clock mux is at the top of every column of an array and the Sector Clock mux is at every four cells. The Column Clock mux is selected from one of the eight Global Clock buses. The clock provided to each sector column of four cells is inverted, non-inverted or tied off to "0", using the Sector Clock mux to minimize the power consumption in a sector that has no clocks.

The clock can either come from the Column Clock or from the Plane 4 express bus. The extreme-left Column Clock mux has two additional inputs, FCK1 and FCK2, to provide fast clocking to left-side I/Os. The extreme-right Column Clock mux has two additional inputs as well, FCK3 and FCK4, to provide fast clocking to right-side I/Os.

The register in each cell is triggered on a rising clock edge by default. Before configuration at power-up, constant "0" is provided to each register's clock pins. After configuration at power-up, the registers either set or reset, depending on the user's choice. The clocking scheme is designed to allow efficient use of multiple clocks with low clock skew, both within a column and across the core cell array.









6.1 Global Clocks

Each of the eight dedicated Global Clock buses is connected to one of the dual-use Global Clock pins. Any clocks used in the design should use global clocks where possible. These signals are distributed across the top edge of the FPGA along special high-speed buses. Global Clock signals can be distributed throughout the FPGA with less than 1 ns skew.

This can be done by using Assign Pin Locks command in the IDS software to lock the clocks to the Global Clock locations.

6.2 Fast Clocks

There are four Fast Clocks (FCK1 - FCK4) on the ATF280E, two per edge column of the array for PCI specification. Even the derived clocks can be routed through the Global network. Access points are provided in the corners of the array to route the derived clocks into the global clock network.

The IDS software tools handle derived clocks to global clock connections automatically if used.

7. Set/Reset Scheme

The ATF280E reset scheme is essentially the same as the clock scheme except that there is only one differential Global Reset. A dedicated Global Set/Reset bus can be driven by any User I/O, except those used for clocking (Global Clocks or Fast Clocks). Like the clocking scheme, set/reset scheme is SET hardened.

The automatic placement tool will choose the reset net with the most connections to use the global resources. You can change this by using an RSBUF component in your design to indicate the global reset. Additional resets will use the express bus network.

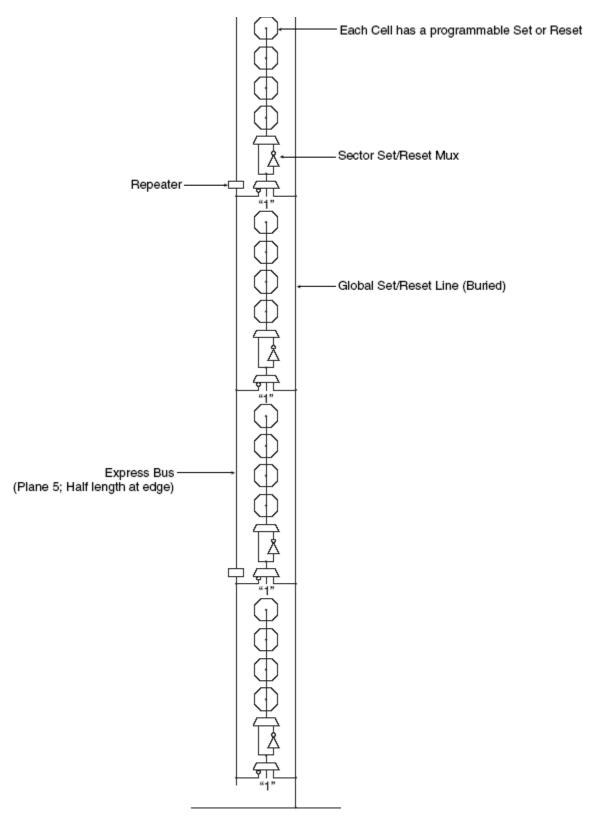
The Global Set/Reset is distributed to each column of the array. Like Sector Clock mux, there is Sector Set/Reset mux at every four cells. Each sector column of four cells is set/reset by a Plane 5 express bus or Global Set/Reset using the Sector Set/Reset mux (Figure 10). The set/reset provided to each sector column of four cells is either inverted or non-inverted using the Sector Reset mux.

The function of the Set/Reset input of a register is determined by a configuration bit in each cell. The Set/Reset input of a register is active low (logic 0) by default. Setting or Resetting of a register is asynchronous. Before configuration on power-up, a logic 1 (a high) is provided by each register (i.e., all registers are set at power-up).





Figure 7-1. Set/Reset (for One Column of Cells)



Any User I/O can drive Global Set/Reset line

28 ATF280E

8. I/O Specifications

The ATF280E provides 2 types of I/O which are all cold sparing:

- programmable I/Os (PCI compatible)
- LVDS I/Os

The ATF280E periphery is divided into 12 clusters. Height clusters are dedicated to programmable I/Os and four clusters are dedicated to LVDS. Each cluster consists in a set of I/O together with its dedicated power supply source.

8.1 Programmable I/Os

Each Programmable I/O cluster has its dedicated power supply source. Programmable I/Os are powered through VCC pads. VDD and VSS power lines are common to all clusters.

Programmable I/O clusters accept 2 different voltages. This feature provides the possibility to use some programmable I/O clusters at either 1.8V or 3.3V.

Each programmable I/O can be configured as input, output or bi-directional. When configured as input an optional Schmitt trigger can be enabled on the I/O. When configured as output optional PCI compatibility can be enabled. In addition it is possible to select the buffer drive to optimize speed of the application.

In addition, the ATF280E provides pull-up and pull-down capability on each I/O. The following section presents all the configuration available on the programmable I/Os

8.1.1 Pull-up/Pull-down

Each pad has a programmable pull-up and pull-down attached to it. This supplies a weak "1" or "0" level to the pad pin. When all other drivers are off, this control will dictate the signal level of the pad pin.

8.1.2 JTAG

8.1.4

All programmable I/Os (including LVDS buffers) are 1149.1 compliant. Each I/O may be included or excluded from boundary scan chain during the configuration of the FPGA.

8.1.3 CMOS

The threshold level of the I/O is CMOS-compatible.

Schmitt A Schmitt trigger circuit can be enabled on the inputs. The Schmitt trigger is a regenerative comparator circuit that adds 0.8V hysteresis to the input. This effectively improves the rise and fall times (leading and trailing edges) of the incoming signal and can be useful for filtering out noise.

- 8.1.5 Delays The input buffer can be programmed to include four different intrinsic delays as specified in the AC timing characteristics. This feature is useful for meeting data hold requirements for the input signal.
- 8.1.6 Drive The output drive capabilities of each I/O are programmable. They can be set to FAST, MEDIUM or SLOW. The FAST setting has the highest drive capability (PCI compatible) buffer and the fastest slew rate. MEDIUM produces a medium drive buffer, while SLOW yields a standard buffer.





Drive capability is dependent upon setting FAST, MEDIUM and SLOW performance and supplies voltage.

Table 8-1.Drive Capability for VCC = 3.3V

VCC = 3.3V	IOh((mA)	IOI(mA)			
config.	Worst case	typical	Worst case	typical		
Slow	13	20	17	30		
Medium	5	8	5	10		
Fast	18.5	29	23	40		

Table 8-2.Drive Capability for VCC = 1.8V

VCC =1.8V	lOh(mA)	IOI(mA)			
config.	Worst case	typical	Worst case	typical		
Slow	6	10	7	15		
Medium	2	4	2	5		
Fast	8	15	10	21		

When no modification is performed by the user on the IDS software, the default configuration of the drive for the I/Os is SLOW.

8.1.7 Tri-State

The output of each I/O can be made tri-state (0, 1 or Z), open source (1 or Z) or open drain (0 or Z) by programming an I/O's Source Selection mux. Of course, the output can be normal (0 or 1), as well.

8.1.8 Dual-use I/O

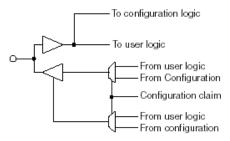
Any pin which functions as user I/O and configuration I/O is a dual-use I/O pin. INIT, HDC, LDC, D0:D15, A0:A19, CS0, CS1, CSOUT, CHECK, and OTS are all dual-use I/O pins.

It must be noted that while the configuration logic controls dual-use I/O pins during a particular mode of operation, the configuration logic does not control the pull-up, pull-down, CMOS/TTL threshold select, or Schmitt trigger selects.

The user must be cautioned to avoid possible system problems with the use of dual-use I/O pins. For example, turning off the internal pull-up resistor for the open drain INIT pin would not apply the weak High required of an open drain driver. Conversely, disabling the pull-up and enabling the pull-down of the HDC pin might be a good idea, since the user may then actually see the pin go Low at the end of configuration.

Dual-use pins share input buffers. It should be noted that even when the configuration has claimed a pin for its own purposes, the user input buffer is still fully functional. This implies that any user logic tied to the input buffers of the pins in question will remain operational.

Figure 8-1. Dual Use I/O principle



8.2 LVDS I/Os

Each LVDS cluster has its dedicated power supply source. LVDS I/Os are powered through VCCB pads. VDD and VSS power lines are common to all clusters.

The LVDS I/Os are composed of 8 LVDS transceiver (Tx) pairs, 8 receivers (Rx) pairs together with 4 reference voltages (Vref). The reference voltage must be connected to an accurate 1.25V voltage to give references to the transceivers and to the receivers.

The LVDS specification complies with the EIA-644 standard requirements.

8.2.1 JTAG

All LVDS I/Os are 1149.1 compliant. Each I/O may be included or excluded from boundary scan chain during the configuration of the FPGA.





9. ATF280E Configuration

Configuration is the process by which a design is loaded into an ATF280E FPGA. The ATF280E device is a SRAM based FPGA. this lead to an unlimited reprogrammability capability.

It is possible to configure either the entire device or only a portions of the device. Sections can be configured while others continue to operate undisturbed. The architecture of the ATF280E leads to a maximum bitstream size of 3M bits. It is possible to store configuration bit-streams of the ATF280E in one single 4Mbit EEPROM.

Full configuration takes only milliseconds. Partial configuration takes even less time and is a function of design density.

Configuration data is transferred to the device in one of the six modes supported by the ATF280E. Three dedicated input pins, M0, M1, and M2 are used to determine the configuration mode.

9.1 Entering Configuration Modes

9.2 Configuration Modes

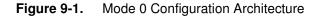
The ATF280E supports an auto-configuring Master mode, four Slave modes, and a Synchronous RAM Mode for accessing the SRAM-based configuration memory directly from a parallel microprocessor port.

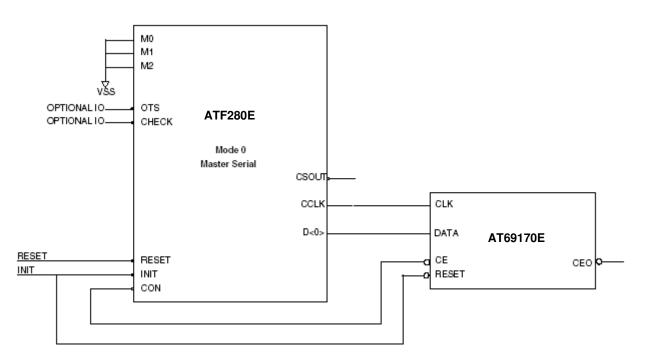
The following table summarizes the ATF280E configuration modes.

Mode	Description	M2	M1	MO	CCLK	Data	Notes
0	Master Serial	0	0	0	Output	Serial	Auto-Configuration Serial EEPROM
1	Slave Serial	0	0	1	Input	Serial	Microprocessor or Serial EEPROM
7	Slave Serial		1	1	Input	Serial	Microprocessor or Serial EEPROM
2	Slave Parallel	0	1	0	Input	8 or 16 bit word	Microprocessor or parallel EEPROM
6	Slave Parallel	1	1	0	Input	8 or 16 bit word	20-bit address out, Parallel EPROM
4	Synchronous RAM	1	0	0	Input	8 or 16 bit word	24-bit Address In, Parallel Port of Microprocessor

Table 9-1.Configuration	Modes
-------------------------	-------

In order to keep the maximum number of pins assigned to signals, it is recommended to use a serial configuration interface. Here is an example of ATF280E serial configuration architecture.





For complete description of all the ATF280E configuration modes please refer to the "AT40K Series Configuration" application note on the ATMEL web site www.atmel.com.

9.3 Configuration Check

The download of the bit-stream from the EEPROM to the FPGA is checked (CRC). Once configured the FPGA will also self check the integrity of the configuration and generate a warning as soon as a difference is detected.





10. Development Software

The ATF280E is designed to quickly implement high performance, large gate count designs through the use of combined Atmel and industry standard tools used on Windows/Linux platform.

11. Power-On Supply Requirements

Atmel FPGAs require a minimum rated power supply current capacity to ensure proper initialization. The power supply ramp-up time affects the current required. A fast ramp-up time requires more current than a slow ramp-up time.

Moreover, the supply voltage must respect a sequence as described below:

The peripheral power up must be done before the core power up. No ramp up is required on VCC power supply.

Table 11-1. Power-on Supply Requirements

Description	Maximum Current(1)(2)
Maximum Current Supply	3 A

- Notes: 1. Devices are guaranteed to initialize properly at 50% of the minimum current listed above. A larger capacity power supply may result in a larger initialization current.
 - 2. 2. Ramp-up time is measured from 0V DC to 1.8V DC. Peak current required lasts less than 2 ms, and occurs near the internal power on reset threshold voltage.





12. Electrical Characteristics

12.1 Absolute Maximum Ratings(1)

Supply Voltage 1.8V I/Os (VCC buffers)0.3V to +2V	
Supply Voltage 3.3V I/Os (VCC buffers)0.3V to +4V	*NOTICE: Stresses at or above those listed under "Abso- lute Maximum Ratings" may cause permanent
Supply Voltage Core (VDD array)0.3V to +2V	damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those
Storage Temperature65°C to +150°C	indicated in the operational sections of this specification is not implied. Exposure to abso- lute maximum rating conditions for extended
All Output Voltages with respect to Ground0.3V to 4V	periods may affect device reliability.
ESD	

12.2 Operating Range

Table 12-1. Operating Range

Operating Temperature	-55°C to +125°C
	3.3V ± 0.3V
VCC - I/O Power Supply	1.8V ± 0.15V
VCCB - LVDS I/O Power Supply	3.3V ± 0.3V
VREF - LVDS Reference Voltage	1.25 ± 0.1V
VDD - Core Power Supply	1.8V ± 0.15V

12.3 DC Characteristics

 Table 12-2.
 DC Characteristics

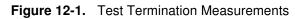
Symbol	Parameter	Conditions	Min	Тур	Max	Units	
VIH	High-level Input Voltage	CMOS	70% Vcc			V	
VIL	Low-level Input Voltage	CMOS	-0.3		30% Vcc	V	
		Iон = -4 mA	0.4			V	
Vон		$V_{CC} = 3.0V$	2.4			v	
	High lovel loout Veltage	Іон = -12 mA	24			v	
	Thigh-level input voltage	Vcc = 3.0V	2.4			v	
		Іон = -16 mA	24			v	
		Vcc = 3.0V	2.7			v	
		$I_{OL} = +4 \text{ mA}$			0.4	-	
		Vcc = 3.0V			0.1	ŀ	
	Low-level Input Voltage	IoL = +12 mA			0.4	v	
	p	Vcc = 3.0V				-	
		$I_{OL} = +16 \text{ mA}$			0.4	v	
		Vcc = 3.0V	-5 5 20 75 300 -5 5 5 -300 -50 -20 cc max -5 5 max 20 300 -5 5 5				
Ін	High-level Input Current	VIN = Vcc max	-			'	
High-level Input Cu		With pull-down, VIN = Vcc		75		•	
lı.	I ow-level Input Current	VIN = VSS	-5		5	μA	
IIL.		With pull-up, V _{IN} = Vss	-300	-50	-20	μA	
Іоzн	High-level Tri-state Output	Without pull-down, Vout =Vcc max	-5		5	μA	
IUZH	Low-level Input Voltage High-level Input Voltage Low-level Input Voltage High-level Input Voltage Low-level Input Voltage High-level Input Voltage Low-level Input Voltage Low-level Input Voltage High-level Input Current Low-level Input Current	With pull-down, Vour = Vcc max	20		300	μA	
I	Low-level Tri-state Output	Without pull-up, Vout = Vss	-5			μA	
Iozl	Leakage Current	With pull-up, Vout = Vss for CON	-500	-150	-110	μA	
lcc	-	Standby, un-programmed		1	5	mA	
CIN	Input Capacitance	All pins			10	pF	
luco	Cold sparing leakage	Vdd = Vss = 0V	2		2		
lics	Input current	Vin = 0 to VDD Max	-2		2	μΑ	
locs	Cold sparing leakage	Vdd = Vss = 0V	-2		2		
locs	output current	Vin = 0 to VDD Max	-2		۷	μΑ	
Vcsтн		locs = 100 μA		0.5		V	

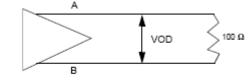




Table 12-3.	LVDS Driver DC/ AC Characteristics
-------------	------------------------------------

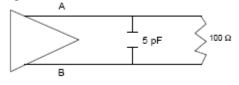
Symbol	Parameter	Test Condition	Min.	Max.	Units	Comments
VOD	Output differential voltage	Rload = 100Ω	251.4	452.2	mV	see Figure below
Vol	Output voltage low	Rload = 100Ω	1071	1731	mV	see Figure below
Voh	Output voltage high	Rload = 100Ω	804	1323	mV	see Figure below
VOS	Output offset voltage	Rload = 100Ω	937	1527	mV	see Figure below
Delta VOD	Change in VOD between "0" and "1"	Rload = 100Ω	0	50	mV	_
Delta VOS	Change in VOS between "0" and "1"	Rload = 100Ω	0	200	mV	_
ISA, ISB	Output current	Drivers shorted to ground or VDD	1.0	6.2	mA	-
ISAB	Output current	Drivers shorted together	2.6	4.8	mA	-
Rbias	Bias resistor	-	16.3	16.7	ΚΩ	
Ibias	Bias static current	-	7	14.6	mA	-
F Max.	Maximum operating frequency	VDD = 3.3V ± 0.3V	-	200	MHz	Consumption 20.9 mA
Clock	Clock signal duty cycle	Max. frequency	45	55	%	-
Tfall	Fall time 80-20%	Rload = 100Ω	445	838	ps	see Figure below
Trise	Rise time 20-80%	Rload = 100Ω	445	841	ps	see Figure below
Тр	Propagation delay	Rload = 100Ω	1120	2120	ps	see Figure below
Tsk1	Duty cycle skew	Rload = 100Ω	0	80	ps	-
Tsk2	Channel to channel skew (same edge)	Rload = 100Ω	0	50	ps	-





$$VOS = \frac{(VA + VB)}{2}$$

Figure 12-2. Rise and Fall times Measurements



Symbol	Parameter	Test Condition	Min.	Max.	Units	Comments
Vi	Input voltage range	_	0	2400	mV	-
Vidth	Input differential voltage	_	-100	+100	mV	-
Тр	Propagation delay	Cout = 50 pF, VDD = 3.3V ± 0.3V	0.7	2.4	ns	-
Tskew	Duty cycle distortion	Cout = 50 pF	-	500	ps	-

Table 12-4. LVDS Receiver DC/ AC Characteristics

12.4 AC Timing Characteristics - TBD

All input I/O characteristics measured from V $_{IH}$ of 50% of V_DD at the pad (CMOS threshold) to the internal V $_{IH}$ of 50% of V_DD.

All output I/O characteristics are measured as the average of TPDLH and TPDHL to the pad VIH of 50% of VDD.

Clocks and Reset Input buffers are measured from a V μ of 1.5V at the input pad to the internal V μ of 50% of Vcc.

Maximum times for clock input buffers and internal drivers are measured for rising edge delays only.

Table 12-5.AC Characteristics

Cell Function	Parameter	Path	Value	Units	Notes
10					
Input	tpd (max)	pad -> x/y		ns	no extra delay
Input	tpd (max)	pad -> x/y		ns	1 extra delay
Input	tpd (max)	pad -> x/y		ns	2 extra delays
Input	tpd (max)	pad -> x/y		ns	3 extra delays
Output, slow	tpd (max)	Output, fast		ns	40 pF load
Output, medium	tpd (max)	Output, fast		ns	40 pF load
Output, fast	tpd (max)	Output, fast		ns	40 pF load
Output, slow	tpd (max)	oe -> pad		ns	40 pF load
Output, slow	tpd (max)	oe -> pad		ns	40 pF load
Output, medium	tpd (max)	oe -> pad		ns	40 pF load
Output, medium	tpd (max)	oe -> pad		ns	40 pF load
Output, fast	tpd (max)	oe -> pad		ns	40 pF load
Output, fast	tpd (max)	oe -> pad		ns	40 pF load
Cell Function	Parameter	Path	Value	Units	Notes
Global Clocks and Se	t/Reset			•	
GCK Input buffer	tpd (max)	pad -> clock		ns	rising edge clock
FCK Input buffer	tpd (max)	pad -> clock		ns	rising edge clock
Clock column driver	tpd (max)	clock -> colclk		ns	rising edge clock
Clock sector driver	tpd (max)	colclk -> secclk		ns	rising edge clock
GSRN Input buffer	tpd (max)	colclk -> secclk		ns	from any pad to Global Set/Reset network





Cell Function	Parameter	Path	Value	Units	Notes
Global clock to output	tpd (max)	clock pad -> out		ns	rising edge clock fully loaded clock tree rising edge DFF 20 mA output buffer 40 pF pin load
Fast clock to output	tpd (max)	clock pad -> out		ns	rising edge clock fully loaded clock tree rising edge DFF 20 mA output buffer 40 pF pin load

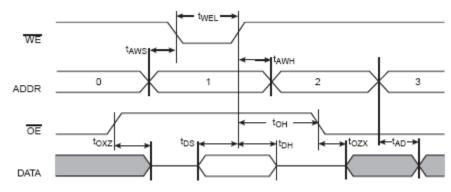
Table 12-6. FreeRAM AC Characteristics

Async RAM				
Write	twecyc (Minimum)	cycle time	ns	
Write	Twel (Minimum)	We	ns	Pulse width low
Write	Tweн (Minimum)	We	ns	Pulse width high
Write	Taws (Minimum)	wr addr setup -> we	ns	
Write	Таwн (Minimum)	wr addr hold -> we	ns	
Write	TDS (Minimum)	din setup -> we	ns	
Write	Тон (Minimum)	din hold -> we	ns	
Write /Read	TDD (Maximum)	din -> dout	ns	rd addr = wr addr
Read	T _{AD} (Maximum)	rd addr -> dout	ns	
Read	Tozx (Maximum)	oe -> dout	ns	
Read	Toxz (Maximum)	oe -> dout	ns	
Sync RAM				
Write	teve (Minimum)	cycle time	ns	
Write	tclkl (Minimum)	Clk	ns	
Write	tclкн (Minimum)	Clk	ns	
Write	twcs (Minimum)	we setup -> clk	ns	
Write	twcн (Minimum)	we hold -> clk	ns	
Write	tacs (Minimum)	wr addr setup -> clk	ns	
Write	tacн (Minimum)	wr addr hold -> clk	ns	
Write	tocs (Minimum)	wr data setup -> clk	ns	
Write	tdcн (Minimum)	wr data hold -> clk	ns	
Write/Read	tcp (Maximum)	clk -> dout	ns	
Read	tad (Maximum)	rd addr -> dout	ns	
Read	tozx (Maximum)	oe -> dout	ns	
Read	toxz (Maximum)	oe -> dout	ns	

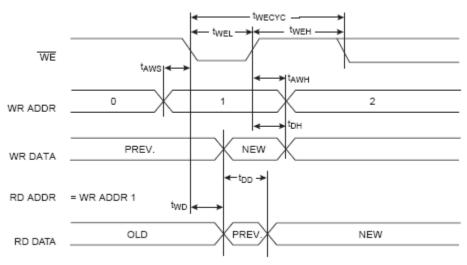
- Notes: 1. CMOS buffer delays are measured from a VIH of 1/2 Vcc at the pad to the internal VIH at A. The input buffer load is constant.
 - 2. Buffer delay is to a pad voltage of 1.5V with one output switching.
 - 3. Parameter based on characterization and simulation; not tested in production.
 - 4. Exact power calculation is available in Atmel FPGA Designer software.

12.4.1 FreeRAM Asynchronous Timing Characteristics

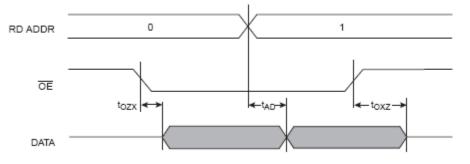
12.4.1.1 Single-port Write/Read



12.4.1.2 Dual-port Write with Read



12.4.1.3 Dual-port Read

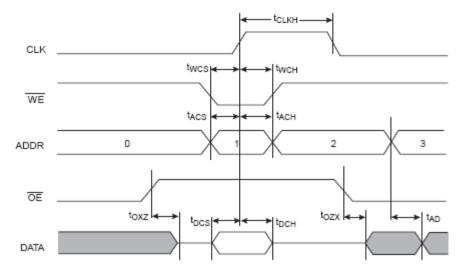


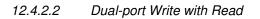


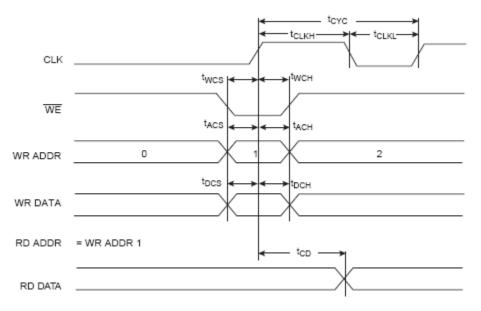


12.4.2 FreeRAM Synchronous Timing Characteristics

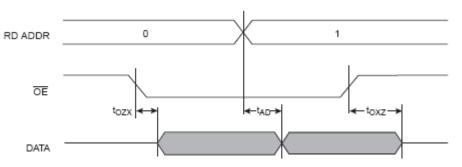
12.4.2.1 Single-port Write/Read







12.4.2.3 Dual-port Read

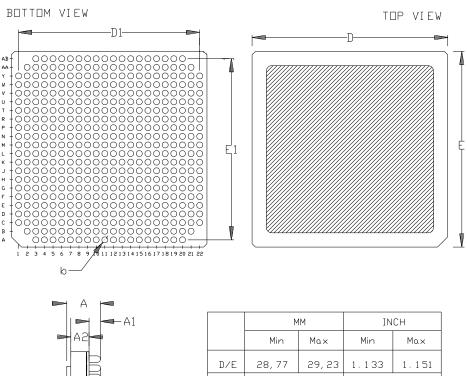


42 **ATF280E**

13. Packaging Information

MCGA 472

MCGA 472 (22 x 22 Pitch : 1,27mm)



D1 /E1

A1

Α2

А

b

е

26,67(1.27x21)

1,85

3. 45 5. 90

0,99

1,27 REF

1,40

2,60

4.30

0,79

1.05(.05×21)

. 050

073

. 136

. 232

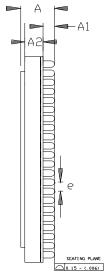
040

. 055

. 102

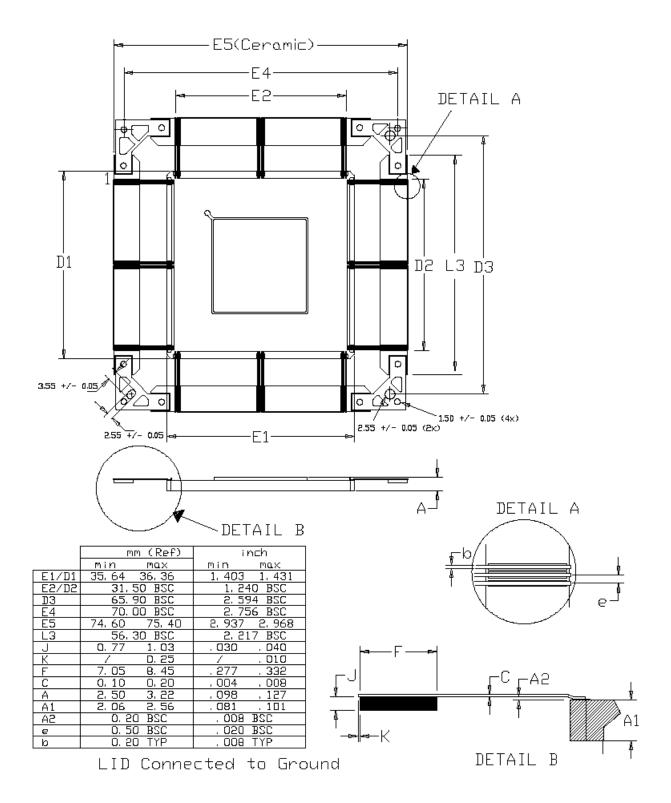
.169

. 031





256-pin MQFPT



ATF280E



Atmel Corporation

2325 Orchard Parkway San Jose, CA 95131, USA Tel: 1(408) 441-0311 Fax: 1(408) 487-2600

Regional Headquarters

Europe

Atmel Sarl Route des Arsenaux 41 Case Postale 80 CH-1705 Fribourg Switzerland Tel: (41) 26-426-5555 Fax: (41) 26-426-5500

Asia

Room 1219 Chinachem Golden Plaza 77 Mody Road Tsimshatsui East Kowloon Hong Kong Tel: (852) 2721-9778 Fax: (852) 2722-1369

Japan

9F, Tonetsu Shinkawa Bldg. 1-24-8 Shinkawa Chuo-ku, Tokyo 104-0033 Japan Tel: (81) 3-3523-3551 Fax: (81) 3-3523-7581

Atmel Operations

Memory 2325 Orchard Parkway San Jose, CA 95131, USA Tel: 1(408) 441-0311 Fax: 1(408) 436-4314

Microcontrollers

2325 Orchard Parkway San Jose, CA 95131, USA Tel: 1(408) 441-0311 Fax: 1(408) 436-4314

La Chantrerie BP 70602 44306 Nantes Cedex 3, France Tel: (33) 2-40-18-18-18 Fax: (33) 2-40-18-19-60

ASIC/ASSP/Smart Cards Zone Industrielle 13106 Rousset Cedex, France Tel: (33) 4-42-53-60-00 Fax: (33) 4-42-53-60-01

1150 East Cheyenne Mtn. Blvd. Colorado Springs, CO 80906, USA Tel: 1(719) 576-3300 Fax: 1(719) 540-1759

Scottish Enterprise Technology Park Maxwell Building East Kilbride G75 0QR, Scotland Tel: (44) 1355-803-000 Fax: (44) 1355-242-743 **RF**/Automotive

Theresienstrasse 2 Postfach 3535 74025 Heilbronn, Germany Tel: (49) 71-31-67-0 Fax: (49) 71-31-67-2340

1150 East Cheyenne Mtn. Blvd. Colorado Springs, CO 80906, USA Tel: 1(719) 576-3300 Fax: 1(719) 540-1759

Biometrics/Imaging/Hi-Rel MPU/ High Speed Converters/RF Datacom Avenue de Rochepleine BP 123 38521 Saint-Egreve Cedex, France Tel: (33) 4-76-58-30-00 Fax: (33) 4-76-58-34-80

Literature Requests www.atmel.com/literature

Disclaimer: The information in this document is provided in connection with Atmel products. No license, express or implied, by estoppel or otherwise, to any intellectual property right is granted by this document or in connection with the sale of Atmel products. EXCEPT AS SET FORTH IN ATMEL'S TERMS AND CONDI-TIONS OF SALE LOCATED ON ATMEL'S WEB SITE, ATMEL ASSUMES NO LIABILITY WHATSOEVER AND DISCLAIMS ANY EXPRESS, IMPLIED OR STATUTORY WARRANTY RELATING TO ITS PRODUCTS INCLUDING, BUT NOT LIMITED TO, THE IMPLIED WARRANTY OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, OR NON-INFRINGEMENT. IN NO EVENT SHALL ATMEL BE LIABLE FOR ANY DIRECT, INDIRECT, CONSEQUENTIAL, PUNITVE, SPECIAL OR INCIDEN-TAL DAMAGES (INCLUDING, WITHOUT LIMITATION, DAMAGES FOR LOSS OF PROFITS, BUSINESS INTERRUPTION, OR LOSS OF INFORMATION) ARISING OUT OF THE USE OR INABILITY TO USE THIS DOCUMENT, EVEN IF ATMEL HAS BEEN ADVISED OF THE POSSIBILITY OF SUCH DAMAGES. Atmel makes no representations or warranties with respect to the accuracy or completeness of the contents of this document and reserves the right to make changes to specifications and product descriptions at any time without notice. Atmel does not make any commitment to update the information contained herein. Unless specifically providedotherwise, Atmel products are not suitable for, and shall not be used in, automotive applications. Atmel's products are not intended, or warranted for use as components in applications intended to support or sustain life.

©2007 Atmel Corporation. All rights reserved. Atmel[®], logo and combinations thereof, are the trademarks or registered trademarks, of Atmel Corporation or its subsidiaries. Other terms and product names may be trademarks of others.

